

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/849,521	IDE, SHIGEO	
	Examiner	Art Unit	Page 1 of 1
Stephen G. Sherman	2629		

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*	B	US-6,862,022	03-2005	Slupe, James P.	345/207
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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